Acta Crystallographica Section E

Structure Reports Online

ISSN 1600-5368

Shi-Gui Tang,^a Dong-Mei Zhang,^b Wen-Yuan Wu,^b Liu Shan^b and Cheng Guo^b*

^aCollege of Life Sciences and Pharmaceuticals, Nanjing University of Technolgy, Xinmofan Road No. 5 Nanjing, Nanjing 210009, People's Republic of China, and ^bDepartment of Applied Chemistry, College of Science, Nanjing University of Technolgy, Xinmofan Road No. 5 Nanjing, Nanjing 210009, People's Republic of China

Correspondence e-mail: guocheng@njut.edu.cn

Key indicators

Single-crystal X-ray study $T=293~\mathrm{K}$ Mean $\sigma(\mathrm{C-C})=0.004~\mathrm{\mathring{A}}$ R factor = 0.061 wR factor = 0.179 Data-to-parameter ratio = 14.9

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

5,5'-Dimethoxy-3,3'-(3-fluorophenyl-methanediyl)bis(1*H*-indole)

The title compound, $C_{25}H_{21}FN_2O_2$, was synthesized by the reaction of 5-methoxy-1H-indole and 3-fluorobenzaldehyde in ethanol, using $CuBr_2$ as a catalyst under microwave irradiation. In the crystal structure, there are two intermolecular hydrogen bonds, one $N-H\cdots O$ and one $C-H\cdots F$, also one intermolecular $N-H\cdots \pi$ (arene) contact.

Received 11 September 2006 Accepted 19 September 2006

Comment

Development of bis(indolyl)alkane synthesis has been of considerable interest because of the wide occurrence of bis-(indolyl)alkanes in various natural products possessing biological activity (Bell *et al.*, 1994) and their usefulness for drug design. We report here the crystal structure of the title compound, (I).

The molecular structure of compound (I) is shown in Fig. 1. Bond lengths and angles are within normal ranges (Allen *et al.*, 1987). Ring *A* comprises atoms C20–C25, ring *B* atoms C5/N1/C6/C7/C8 and ring *C* atoms C14/N2/C15/C16/C17. The various dihedral angles are A/C = 109.4 (2)°, B/C = 94.4 (1)° and A/B = 80.0 (2)°.

The crystal structure of (I) is stabilized by two intermolecular $N-H\cdots O$ and $C-H\cdots F$ hydrogen bonds and one intermolecular $N-H\cdots \pi$ (arene) contact (Fig. 2 and Table 1; Cg1 is the centroid of atoms C11–C14/C17/C18). The $N-H\cdots O$ hydrogen bond and $N-H\cdots \pi$ (arene) contact are also present in a very similar compound, in which the fluoro group is replaced by a nitro group (Guo *et al.*, 2006).

Experimental

Compound (I) was prepared by the reaction of 5-methoxy-1H-indole (20 mmol) with 3-fluorobenzaldehyde (10 mmol) in ethanol (5 ml), using CuBr₂ (0.446 g) as catalyst under microwave irradiation

© 2006 International Union of Crystallography All rights reserved

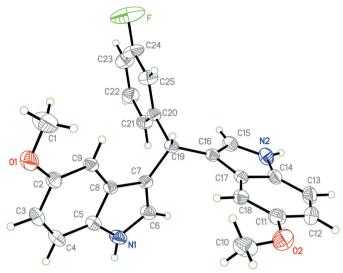


Figure 1The molecular structure of (I), showing the atom-labelling scheme. Displacement ellipsoids are drawn at the 30% probability level.

(280 W) for 10 min. After completion, the reaction mixture was quenched with H_2O (10 ml) and extracted with EtOAc (3 × 10 ml). The combined organic layers were dried over Na_2SO_4 , concentrated, and purified by column chromatography on SiO_2 (ethyl acetate-petroleum ether 1:3 ν/ν) to afford the pure product, (I) (m.p. 472–475 K). Crystals of (I) suitable for X-ray diffraction were obtained by slow evaporation of a methanol solution.

Crystal data

 $C_{25}H_{21}FN_2O_2$ Z=4

 $M_r=400.44$ $D_x=1.284 \text{ Mg m}^{-3}$

 Monoclinic, $P2_1/n$ Mo $K\alpha$ radiation

 a=9.1910 (18) Å
 $\mu=0.09 \text{ mm}^{-1}$

 b=10.838 (2) Å
 T=293 (2) K

 c=20.879 (4) Å
 Block, colourless

 $\beta=94.92$ (3)°
 $0.40 \times 0.30 \times 0.30 \text{ mm}$

 V=2072.1 (7) ų

Data collection

Enraf-Nonius CAD-4 diffractometer $\omega/2\theta$ scans Absorption correction: ψ scan (North et al., 1968) $T_{\min} = 0.964$, $T_{\max} = 0.976$ 4322 measured reflections

Refinement

Refinement on F^2 $R[F^2 > 2\sigma(F^2)] = 0.061$ $wR(F^2) = 0.179$ S = 1.04 4062 reflections 272 parameters H-atom parameters constrained 4062 independent reflections 2600 reflections with $I > 2\sigma(I)$ $R_{\rm int} = 0.021$ $\theta_{\rm max} = 26.0^{\circ}$ 3 standard reflections every 200 reflections intensity decay: none

$$w = 1/[\sigma^{2}(F_{o}^{2}) + (0.0792P)^{2} + 0.9173P]$$
where $P = (F_{o}^{2} + 2F_{c}^{2})/3$

$$(\Delta/\sigma)_{\text{max}} = 0.023$$

$$\Delta\rho_{\text{max}} = 0.38 \text{ e Å}^{-3}$$

$$\Delta\rho_{\text{min}} = -0.27 \text{ e Å}^{-3}$$
Extinction correction: $SHELXL97$
(Sheldrick, 1997)
Extinction coefficient: 0.025 (2)

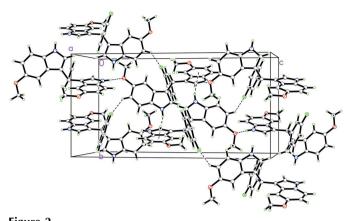


Figure 2 The crystal structure of (I). Dashed lines indicate $N-H\cdots O$, $C-H\cdots F$ and $N-H\cdots \pi$ contacts.

Table 1 Hydrogen-bond geometry (Å, °).

$D-H\cdots A$	$D-\mathrm{H}$	$H \cdot \cdot \cdot A$	$D \cdot \cdot \cdot A$	$D-\mathrm{H}\cdots A$
$ \begin{array}{c} N2-H2A\cdotsO1^{i}\\C3-H3A\cdotsF^{ii}\\N1-H1A\cdots Cg1 \end{array} $	0.86	2.16	2.946 (3)	152
	0.93	2.51	3.264 (4)	138
	0.86	2.46	3.277 (2)	159

Symmetry codes: (i) $x - \frac{1}{2}$, $-y + \frac{1}{2}$, $z + \frac{1}{2}$; (ii) $-x + \frac{1}{2}$, $y + \frac{1}{2}$, $-z + \frac{1}{2}$.

All H atoms were placed in idealized positions and refined as riding, with C—H = 0.93–0.98 Å and N—H = 0.86 Å, and with $U_{\rm iso}({\rm H})$ = $xU_{\rm eq}({\rm parent\ atom})$, where x = 1.5 for methyl H and 1.2 for all other H atoms.

Data collection: *CAD-4 Software* (Enraf–Nonius, 1989); cell refinement: *CAD-4 Software*; data reduction: *XCAD4* (Harms & Wocadlo, 1995); program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *SHELXTL* (Siemens, 1996); software used to prepare material for publication: *SHELXTL*.

The authors thank the Centre for Testing and Analysis, Nanjing University, for support.

References

Allen, F. H., Kennard, O., Watson, D. G., Brammer, L., Orpen, A. G. & Taylor, R. (1987). J. Chem. Soc. Perkin Trans. 2, pp. S1–19.

Bell, R., Carmeli, S., Sar, N. & Vibrindole, A. (1994). J. Nat. Prod. 57, 1587– 1590.

Enraf-Nonius (1989). *CAD-4 Software*. Version 5.0. Enraf-Nonius, Delft, The Netherlands.

Guo, C., Zhang, D.-M., Tang, Q.-G. & Sun, H.-S. (2006). Acta Cryst. E62, o3994–o3995.

Harms, K. & Wocadlo, S. (1995). XCAD4. University of Marburg, Germany. North, A. C. T., Phillips, D. C. & Mathews, F. S. (1968). Acta Cryst. A24, 351–359.

Sheldrick, G. M. (1997). SHELXS97 and SHELXL97. University of Göttingen, Germany.

Siemens (1996). SHELXTL. Version 5.06. Siemens Analytical X-ray Instruments Inc., Madison, Wisconsin, USA.